SN54BCT623, SN74BCT623 OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SCBS020A - SEPTEMBER 1988 - REVISED NOVEMBER 1993

- State-of-the-Art BiCMOS Design Significantly Reduces I_{CCZ}
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015
- **Package Options Include Plastic** Small-Outline (DW) Packages, Ceramic Chip Carriers (FK) and Flatpacks (W), and Plastic and Ceramic 300-mil DIPs (J, N)

description

The 'BCT623 bus transceiver is designed for asynchronous communication between data buses. The control function implementation allows for maximum flexibility in timing. The 'BCT623 provides true data at its outputs.

This device allows data transmission from the A bus to the B bus or from the B bus to the A bus depending upon the logic levels at the output-enable (OEAB and OEBA) inputs.

The output-enable inputs can be used to disable the device so that the buses are effectively isolated. The dual-enable configuration gives the transceivers the capability of storing data by simultaneously enabling OEAB and OEBA. Each output reinforces its input in this configuration. When both OEAB and OEBA are enabled and all other data sources to the two sets of bus lines are at high impedance, both sets of bus lines (16 in all) will remain at their last states.

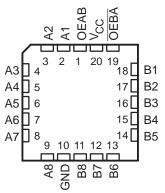
The SN54BCT623 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74BCT623 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE							
INP	UTS						
OEBA	OEAB	OPERATION					
L	L	B data to A bus					
L	Н	B data to A bus, A data to B bus					
Н	L	Isolation					
Н	Н	A data to B bus					

SN54BCT623.	J OR W PACKAGE
SN74BCT623	. DW OR N PACKAGE
(то	OP VIEW)

OEAB	$_{1}$ U	20	<u>v_{cc}</u>
A1 [2	19	OEBA
A2 [3	18] B1
A3	4	17] B2
A4 [5	16] вз
A5 🛛	6	15] B4
A6 [7	14] B5
A7 [8	13] B6
A8 [9	12] B7
GND [10	11	B8

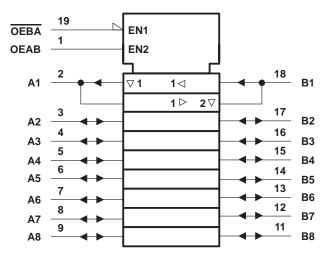
SN54BCT623 ... FK PACKAGE (TOP VIEW)



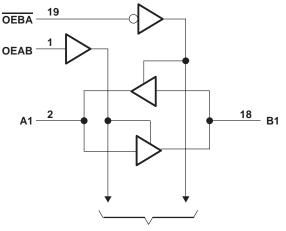
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logic symbol[†]



logic diagram (positive logic)



To Seven Other Channels

⁺ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC}		– 0.5 V to 7 V
Input voltage range: Control inputs (se	e Note 1)	$\dots \dots $
I/O ports (see Not	e 1)	$\dots \dots $
Voltage range applied to any output in	the disabled or power-off state, VO	$\dots \dots $
Voltage range applied to any output in	the high state, V _O	$\dots \dots \dots \dots - 0.5$ V to V _{CC}
Input clamp current, IIK	•	
Current into any output in the low state		
	SN74BCT623	128 mA
Operating free-air temperature range:	SN54BCT623	– 55°C to 125°C
	SN74BCT623	0°C to 70°C
Storage temperature range		– 65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

				SN54BCT623		SN74BCT623			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage		2			2			V
VIL	Low-level input voltage				0.8			0.8	V
Iк	Input clamp current				-18			-18	mA
1		A port		-3			-3	m A	
ЮН	High-level output current	B port			-12			-15	mA
1	IOL Low-level output current	A port			20			24	A
IOL		B port			48			64	mA
TA	Operating free-air temperature		-55		125	0		70	°C



SN54BCT623, SN74BCT623 **OCTAL BUS TRANSCEIVERS** WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN	SN54BCT623			SN74BCT623			
I	PARAMETER	TEST CONDITIONS		MIN	MIN TYP [†] N		MIN	TYP†	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	lj = -18 mA			-1.2			-1.2	V	
	Aport		I _{OH} = -1 mA	2.5	3.4		2.5	3.4			
	A port	$V_{CC} = 4.5 V$	$I_{OH} = -3 \text{ mA}$	2.4	3.3		2.4	3.3			
VOH			$I_{OH} = -3 \text{ mA}$	2.4	3.3		2.4	3.3		V	
	B port	$V_{CC} = 4.5 V$	$I_{OH} = -12 \text{ mA}$	2	3.2						
			I _{OH} = -15 mA				2	3.1			
	A port	V _{CC} = 4.5 V	I _{OL} = 20 mA		0.3	0.5					
VOL	Apon	VCC = 4.3 V	I _{OL} = 24 mA					0.35	0.5	V	
VOL	B port	$V_{CC} = 4.5 V$	I _{OL} = 48 mA		0.38	0.55				v	
	D port	VCC = 4.5 V	I _{OL} = 64 mA					0.42	0.55		
1.	A or B port	V _{CC} = 5.5 V,	VI = 5.5 V			1			1	mA	
1	OEAB or OEBA	VCC = 0.5 V,	v] = 3.3 v			0.1			0.1	ША	
IIH‡	A or B port	V _{CC} = 5.5 V,	VI = 2.7 V			70			70	μA	
ΠH∓	OEAB or OEBA	VCC = 0.5 V,	V] = 2.7 V			20			20	μΛ	
ı _{IL} ‡	A or B port	V _{CC} = 5.5 V,	V _I = 0.5 V			-0.65			-0.65	mA	
٩Ľ	OEAB or OEBA	V(() = 0.0 V,	1 - 0.0 1			-0.6			-0.6	110/ (
IOS§	A port	V _{CC} = 5.5 V,	$V_{O} = 0$	-60		-150	-60		-150	mA	
IOS3	B port	VCC = 0.5 V,	V O = 0	-100		-225	-100		-225	ША	
ICCL	A to B	V _{CC} = 5.5 V			58	92		58	92	mA	
ІССН	A to B	$V_{CC} = 5.5 V$			33	53		33	53	mA	
ICCZ		V _{CC} = 5.5 V			6	11		6	11	mA	
Ci	OEAB or OEBA	V _{CC} = 5 V,	VI = 2.5 V or 0.5 V		5			5		pF	
C:-	A to B	V _{CC} = 5 V,	V _O = 2.5 V or 0.5 V		9			9		рF	
Cio	B to A	VCC - 5 V,	VO - 2.5 V 01 0.5 V		12			12		Рі	

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. [‡] For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current. § Not more than one output should be tested at a time, and the duration of the test should not exceed one second.



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switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	то (оитрит)	V _{CC} = 5 V, C _L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T _A = 25°C		CL = 50 pF, R1 = 500 Ω, TO R2 = 500 Ω,			$\begin{array}{c c} C_L = 50 \ \text{pF}, & C_L = 50 \ \text{pF}, \\ R1 = 500 \ \Omega, & R1 = 500 \ \Omega, \\ \text{(OUTPUT)} & T_A = 25^\circ \text{C} & T_A = \text{MIN to MAX}^{\dagger} \end{array}$						UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX					
^t PLH	A	В	0.5	3.1	4.7	0.5	5.3	0.5	5.2					
^t PHL		В	1.7	4.9	6.9	1.7	7.6	1.7	7.4	ns				
^t PLH	В	А	0.9	4.1	5.9	0.9	6.8	0.9	6.7	ns				
^t PHL		A	1.8	5.3	7.6	1.8	8.3	1.8	8	115				
^t PZH	OEBA	А	3.1	6.8	9.1	3.1	10.7	3.1	10.6	ns				
^t PZL	UEBA	~	3.3	7.2	9.6	3.3	11.3	3.3	10.7	115				
^t PHZ	OEBA	А	1.9	6.1	8.3	1.9	10.6	1.9	9.8	ns				
^t PLZ	UEBA	A	1.1	4.6	7	1.1	8.1	1.1	7.8	115				
^t PZH	OEAB	OFAB B	2	5	6.8	2	7.8	2	7.6	ns				
^t PZL		0	2.7	6.2	8	2.7	9.3	2.7	8.9	115				
^t PHZ	OEAB	В	1.1	4.6	6.5	1.1	8	1.1	7.7	ns				
^t PLZ	OLAD	6	0.3	3.2	6.3	0.3	7.2	0.3	7.1	115				

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



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